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INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO-1449

APPLICANT Franz LAERMER

FILING DATE To be assigned **GROUP** To be assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
/RD/	US 2002/074946 *	June 20, 2002	Tetsuya et al.	· · -	 	
I.	4,472,254 *	September 18, 1984	Dotson et al.			
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^{*} Copy of reference is not enclosed because reference is cited and described in Search Report (copy of reference provided by the International Searching Authority).

FOREIGN PATENT DOCUMENTS

						TRANSLATION	
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	00 51938 *	September 8, 2000	WO				士
	2001 267241 *	September 28, 2001	JP				_
	2 332 302	June 10, 1999	GB.				+
	199 19 469 +, ++	November 2, 2000	DE				_
/RD/	08-153711	June 11, 1996	JР			Abstract	
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	Joudan et al., "Recent Developments in Fluorine Chemistry for Microelectronic Applications -
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EXAMINER	/Rakesh Dhingra/	DATE CONSIDERED	03/26/2007			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						